



**International  
Standard**

**ISO/IEC 19763-3**

**Information technology —  
Metamodel framework for  
interoperability (MFI) —**

**Part 3:**

**Metamodel for ontology registration**

**AMENDMENT 1: Alignment with  
Edition 4 of ISO/IEC 11179-3**

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Phone: +41 22 749 01 11  
Email: [copyright@iso.org](mailto:copyright@iso.org)  
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